



# HRLT1B0N10K

## 100V N-Channel Trench MOSFET

### Features

- ESD Protect
- Reliable and Rugged
- High Density Cell Design for Ultra Low  $R_{DS(on)}$
- 100% Avalanche Tested
- RoHS Compliant

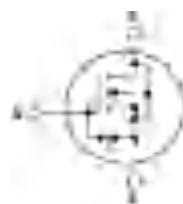
### Key Parameters

Parameter	Value	Unit
$BV_{DSS}$	100	V
$I_D$	3.5	A
$R_{DS(on)}$ , typ @10V	85	mΩ
$R_{DS(on)}$ , typ @4.5V	100	mΩ

SOT-223



Symbol



### Absolute Maximum Ratings

$T_J=25^\circ\text{C}$  unless otherwise specified

Symbol	Parameter	Value	Unit
$V_{DSS}$	Drain-Source Voltage	100	V
$V_{GS}$	Gate-Source Voltage	$\pm 20$	V
$I_D$	Drain Current	$T_A = 25^\circ\text{C}$	A
		$T_A = 70^\circ\text{C}$	A
$I_{DM}$	Pulsed Drain Current	14	A
$E_{AS}$	Single Pulsed Avalanche Energy	$L=1\text{mH}$	$\mu\text{J}$
$P_D$	Power Dissipation	$T_A = 25^\circ\text{C}$	W
		$T_A = 70^\circ\text{C}$	W
$T_J, T_{STG}$	Operating and Storage Temperature Range	-55 to +150	°C

### Thermal Resistance Characteristics

Symbol	Parameter	Value	Unit
$R_{\theta JA}$	Junction-to-Ambient (1 in <sup>2</sup> pad of 2 oz copper), Max.	60	°C/W

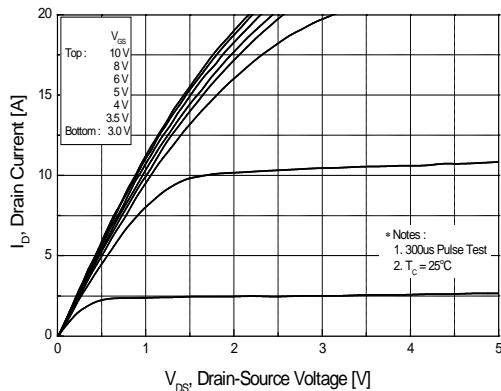
**Electrical Characteristics**  $T_J=25\text{ }^\circ\text{C}$  unless otherwise specified

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
<b>On Characteristics</b>						
$V_{GS}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$ , $I_D = 250\text{ }\mu\text{A}$	1.5	--	2.5	V
$R_{DS(ON)}$	Static Drain-Source On-Resistance	$V_{GS} = 10\text{ V}$ , $I_D = 3.5\text{ A}$	--	85	105	$\text{m}\Omega$
		$V_{GS} = 4.5\text{ V}$ , $I_D = 2.0\text{ A}$	--	100	140	$\text{m}\Omega$
$g_{FS}$	Forward Transconductance	$V_{DS} = 5\text{ V}$ , $I_D = 3.5\text{ A}$	--	12	--	S
<b>Off Characteristics</b>						
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS} = 0\text{ V}$ , $I_D = 250\text{ }\mu\text{A}$	100	--	--	V
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = 80\text{ V}$ , $V_{GS} = 0$	--	--	1	$\mu\text{A}$
		$V_{DS} = 80\text{ V}$ , $T_J = 85\text{ }^\circ\text{C}$	--	--	30	$\mu\text{A}$
$I_{GSS}$	Gate-Body Leakage Current	$V_{GS} = \pm 16\text{ V}$ , $V_{DS} = 0\text{ V}$	--	--	$\pm 10$	$\mu\text{A}$
<b>Dynamic Characteristics</b>						
$C_{iss}$	Input Capacitance	$V_{DS} = 50\text{ V}$ , $V_{GS} = 0\text{ V}$ , $f = 1.0\text{ MHz}$	--	970	--	pF
$C_{oss}$	Output Capacitance		--	52	--	pF
$C_{rss}$	Reverse Transfer Capacitance		--	32	--	pF
<b>Switching Characteristics</b>						
$t_{d(on)}$	Turn-On Time	$V_{DS} = 50\text{ V}$ , $I_D = 3.5\text{ A}$ , $R_G = 25\text{ }\Omega$ (Note 2,3)	--	17	--	ns
$t_r$	Turn-On Rise Time		--	24	--	ns
$t_{d(off)}$	Turn-Off Delay Time		--	85	--	ns
$t_f$	Turn-Off Fall Time		--	12	--	ns
$Q_{g(10V)}$	Total Gate Charge	$V_{DS} = 80\text{ V}$ , $I_D = 3.5\text{ A}$ , $V_{GS} = 10\text{ V}$ (Note 2,3)	--	20	26	nC
$Q_{g(4.5V)}$	Total Gate Charge		--	10	--	nC
$Q_{gs}$	Gate-Source Charge		--	3.0	--	nC
$Q_{gd}$	Gate-Drain Charge		--	4.2	--	nC
<b>Drain-Source Diode Characteristics and Maximum Ratings</b>						
$I_S$	Maximum Continuous Drain-Source Diode Forward Current	--	--	3.5	A	
$I_{SM}$	Maximum Pulsed Drain-Source Diode Forward Current	--	--	14	A	
$V_{SD}$	Drain-Source Diode Forward Voltage	$I_S = 3.5\text{ A}$ , $V_{GS} = 0\text{ V}$	--	--	1.1	V
$trr$	Reverse Recovery Time	$I_S = 3.5\text{ A}$ , $dI_F/dt = 100\text{ A}/\mu\text{s}$	--	36	--	ns
$Qrr$	Reverse Recovery Charge		--	50	--	nC

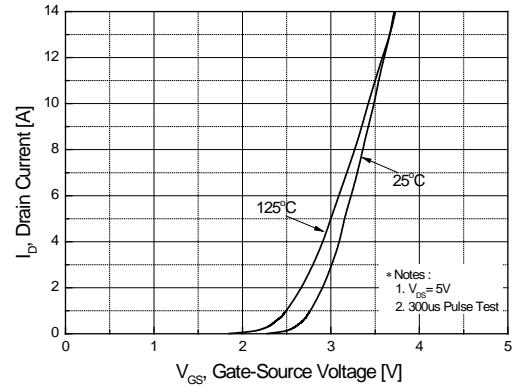
**Notes :**

1. Repetitive Rating : Pulse width limited by maximum junction temperature
2. Pulse Test : Pulse Width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 2\%$
3. Essentially Independent of Operating Temperature

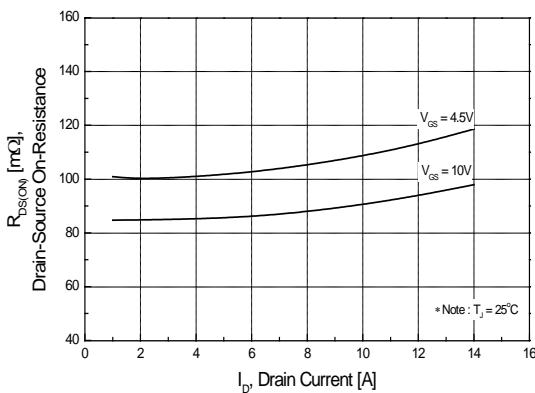
## Typical Characteristics



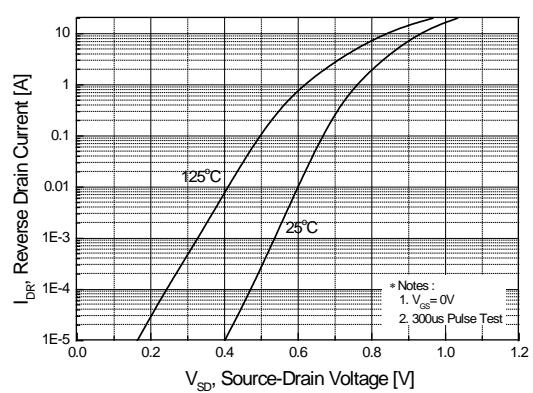
**Figure 1. On Region Characteristics**



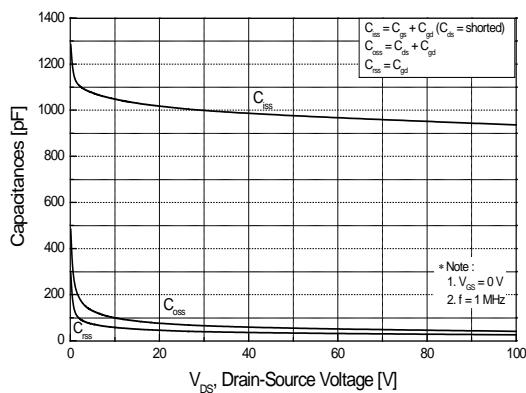
**Figure 2. Transfer Characteristics**



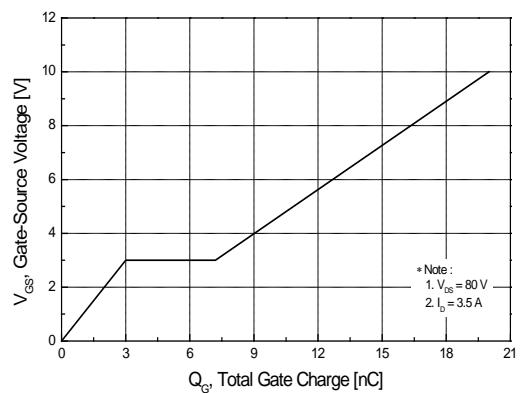
**Figure 3. On Resistance Variation vs. Drain Current and Gate Voltage**



**Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature**

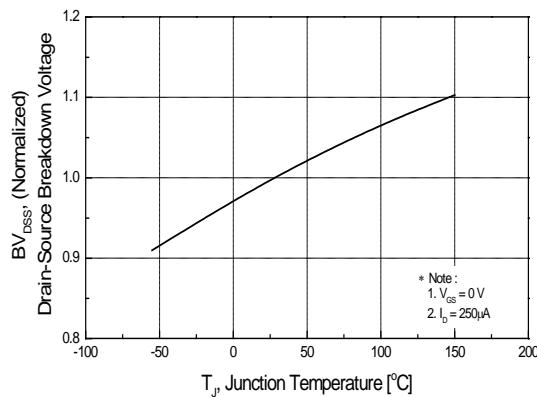


**Figure 5. Capacitance Characteristics**

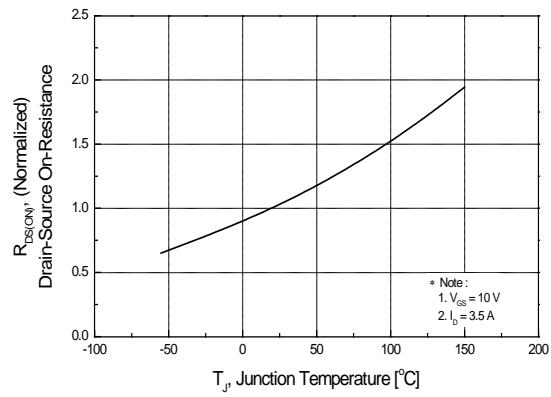


**Figure 6. Gate Charge Characteristics**

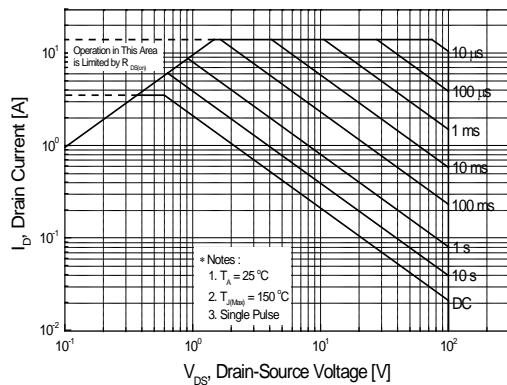
## Typical Characteristics (continued)



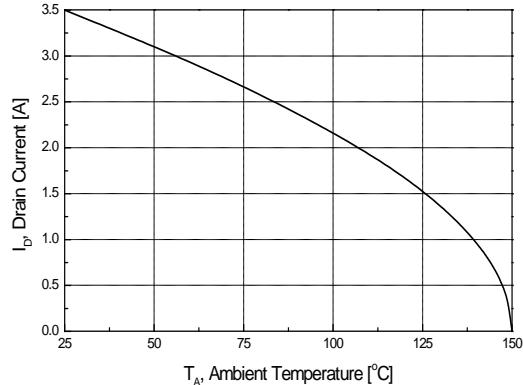
**Figure 7. Breakdown Voltage Variation vs Temperature**



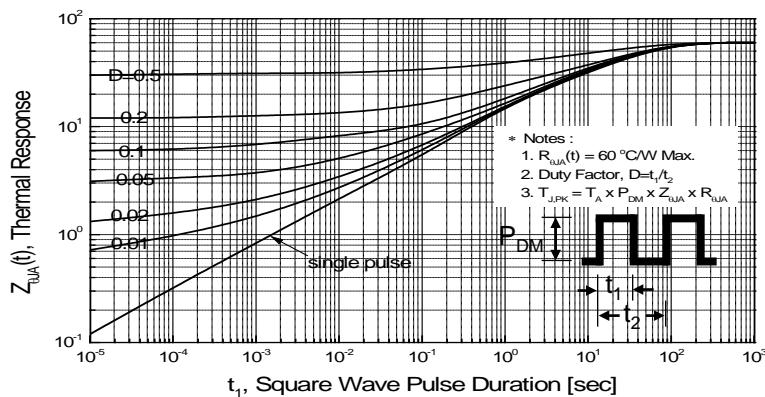
**Figure 8. On-Resistance Variation vs Temperature**



**Figure 9. Maximum Safe Operating Area**



**Figure 10. Maximum Drain Current vs Case Temperature**



**Figure 11. Transient Thermal Response Curve**

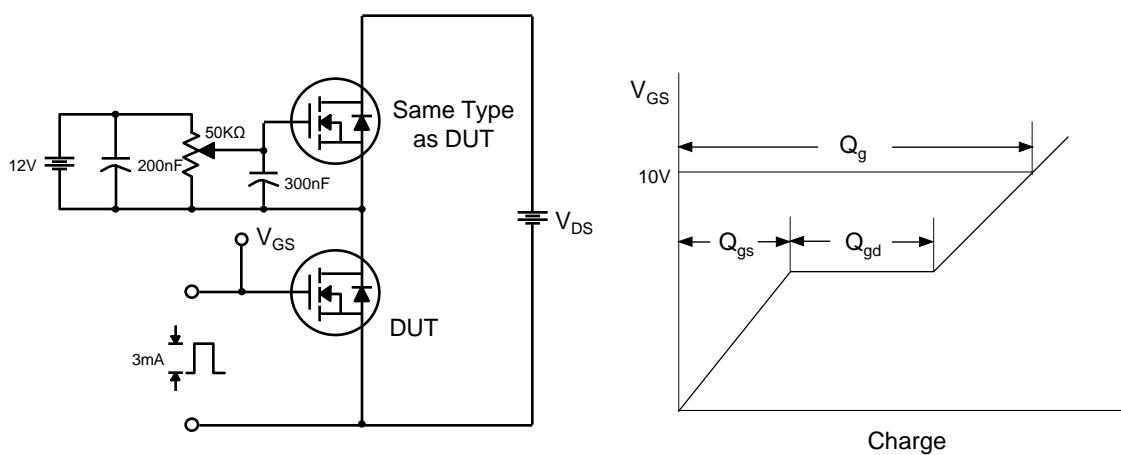
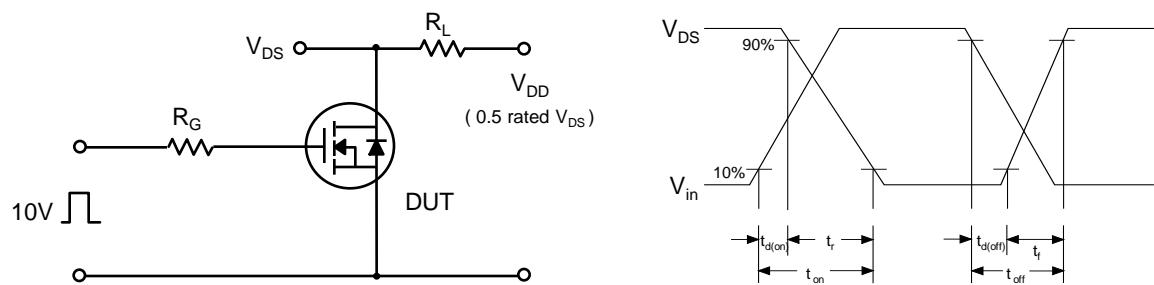
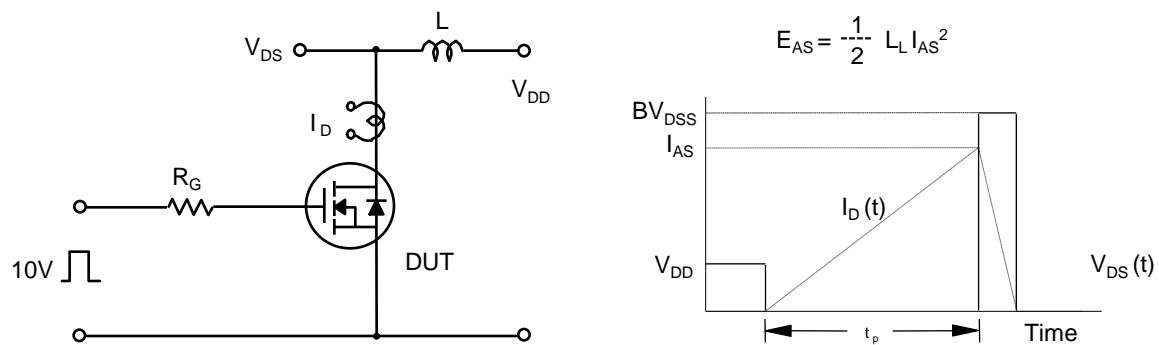
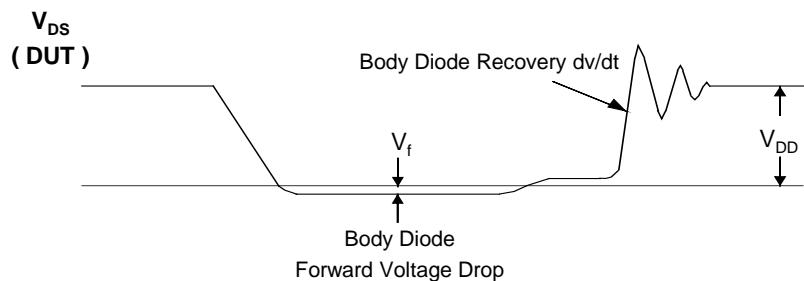
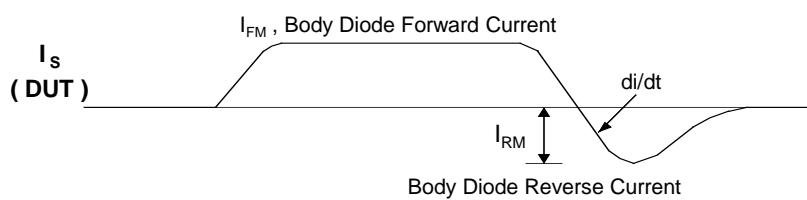
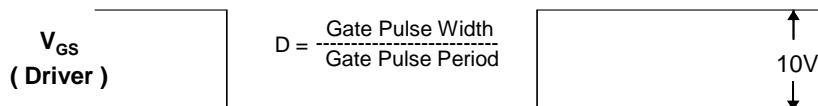
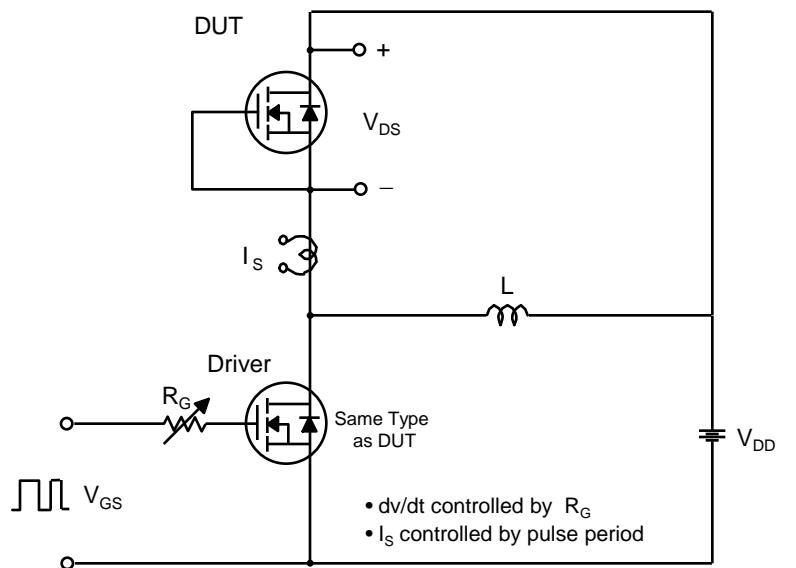
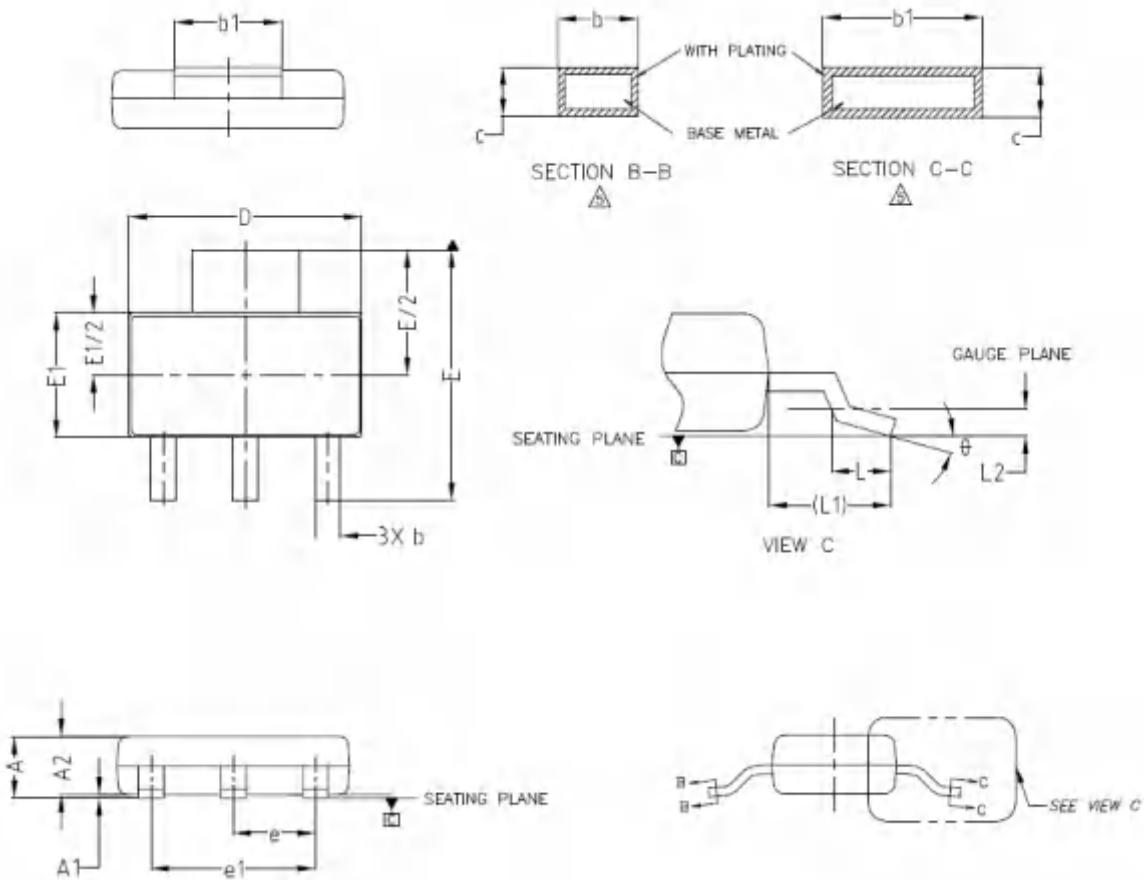
**Fig 12. Gate Charge Test Circuit & Waveform****Fig 13. Resistive Switching Test Circuit & Waveforms****Fig 14. Unclamped Inductive Switching Test Circuit & Waveforms**

Fig 15. Peak Diode Recovery dv/dt Test Circuit &amp; Waveforms



## Package Dimension

SOT-223



SYMBOL	MILLIMETERS			NOTE
	MINIMUM	NOMINAL	MAXIMUM	
A	—	—	1.52	
A1	0.05	—	0.10	
A7	1.63	1.85	1.78	
b	0.95	—	0.76	5
b1	2.95	—	3.07	5
c	0.25	—	0.18	4
D	6.18	6.50	6.66	1.5
E	10.35	7.00	7.20	
E1	3.43	3.50	3.60	2.5
e	2.50 BSC			
e1	4.60 BSC			
L	0.15	—	0.165	
L1	1.75 REF			
L2	1.10 BSC			
$\theta$	7°	—	10°	
$\theta$	5°	—	7°	